

Certificate of Analysis

MBH-13X NSC5 C

Nitrogen Stainless Steel (Chill-Cast)

Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

Al	0.24 ± 0.01	C	0.524 ± 0.007	Co	0.093 ± 0.004	Cr	21.6 ± 0.2
Cu	0.84 ± 0.02	Mn	2.06 ± 0.02	Mo	0.472 ± 0.007	N	0.265 ± 0.004
Nb	2.31 ± 0.03	Ni	4.42 ± 0.03	S	0.024 ± 0.001	Si	1.18 ± 0.03
V	0.102 ± 0.003	W	0.050 ± 0.002				

Description and Intended Use

This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** certified laboratories. This CRM may come in the form of a solid disk or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Instructions for Use

1. The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface.
2. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams.
3. The material should be stored in a cool, dry location when not in use.
4. Chips are not recommended for gas analysis.

The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Al	C	Co	Cr	Cu	Mn	Mo	N	Nb	Ni	S	Si	V	W
1	0.2020	0.4890	0.0846	20.781	0.7634	1.9830	0.4480	0.2564	2.2283	4.3062	0.0195	1.0738	0.0920	0.0414
2	0.2187	0.5061	0.0881	21.093	0.7740	2.0160	0.4498	0.2599	2.2534	4.3131	0.0186	1.1123	0.0941	0.0440
3	0.2200	0.5118	0.0889	21.483	0.8293	2.0250	0.4580	0.2603	2.2588	4.3490	0.0207	1.1360	0.0983	0.0472
4	0.2270	0.5154	0.0890	21.528	0.8311	2.0330	0.4630	0.2643	2.2610	4.3540	0.0229	1.1590	0.0993	0.0492
5	0.2380	0.5170	0.0896	21.573	0.8330	2.0466	0.4710	0.2650	2.2760	4.3790	0.0240	1.1690	0.1002	0.0495
6	0.2394	0.5209	0.0898	21.640	0.8360	2.0480	0.4710	0.2670	2.2820	4.4140	0.0241	1.1740	0.1010	0.0499
7	0.2400	0.5260	0.0913	21.650	0.8557	2.0543	0.4721	0.2673	2.3219	4.4142	0.0241	1.1890	0.1020	0.0506
8	0.2410	0.5290	0.0925	21.670	0.8560	2.0560	0.4734	0.2727	2.3280	4.4490	0.0249	1.1921	0.1030	0.0508
9	0.2423	0.5300	0.0952	21.710	0.8608	2.0650	0.4754	0.2733	2.3532	4.4510	0.0254	1.1927	0.1030	0.0510
10	0.2442	0.5310	0.0957	21.742	0.8615	2.0698	0.4780	0.2720	2.3540	4.4520	0.0258	1.1950	0.1037	0.0514
11	0.2454	0.5313	0.0962	21.764	0.8621	2.1057	0.4841	0.2545	2.3560	4.4673	0.0264	1.2210	0.1075	0.0517
12	0.2539	0.5320	0.1130	22.250	0.8719	2.1219	0.4880		2.3597	4.5110	0.0266	1.2306	0.1088	0.0529
13	0.2610	0.5337	0.0934	22.348	0.8843	2.1490	0.4979		2.3580	4.5253	0.0273	1.2647	0.1155	0.0560
14	0.2410	0.5380	0.0895	21.516	0.8550	2.0310	0.4630		2.3217	4.4770	0.0273	1.1700	0.1051	0.0553
15	0.2895	0.5320	0.0974	21.130	0.8495	2.0900	0.4760			4.4050	0.0244	1.1325		0.0450
16	0.2546	0.5360		21.691	0.8516	2.0183	0.4840			4.4100	0.0264	1.2092		0.0516
17											0.0263			
18														
19														
Mean	0.2411	0.5237	0.0929	21.598	0.8422	2.0570	0.4720	0.2648	2.3080	4.4173	0.0244	1.1763	0.1024	0.0498
STDV.	0.0197	0.0131	0.0066	0.3860	0.0324	0.0428	0.0134	0.0065	0.0465	0.0650	0.0026	0.0472	0.0059	0.0039
Certified	0.24	0.524	0.093	21.6	0.84	2.06	0.472	0.265	2.31	4.42	0.024	1.18	0.102	0.050
U _{CRM}	0.01	0.007	0.004	0.2	0.02	0.02	0.007	0.004	0.03	0.03	0.001	0.03	0.003	0.002
Methods	I,W,A	C	I,W,A	I,W	I,W,A	I,W,A	I	F	I,W,A	I,W,A	C,I	I,W	I,W,A	I,W,A

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

Certification Laboratories

Element - Teeside	Middlesbrough, England	TUV Nord-Czech	Brno, Czech Republic
Sheffield Analytical Services	Sheffield, England	Metals Technology (Testing) Ltd	Sheffield, England
AMG Superalloys UK Ltd	Rotherham, England	Laboratory Testing, Inc	Hatfield, PA
Mineral & Metallurgical Laboratories	Bangalore, India	Tec-Eurolab	Campogalliano, Italy
Instytut Metalurgii Zelaza	Gliwice, Poland	Universal Scientific Laboratory Pty Ltd	Sydney, Australia
Luo Yang Copper Co	Luo Yang, He Nan, China	Genitest Inc	Montreal, Canada
Raghavendra SpectroMet Laboratory	Bangalore, India	TCR Engineering Services Ltd	Mumbai, India
Anchorcert Analytical	Birmingham, England	Shanghai Jinyi Test Tech Co	Shanghai, China
Analyticka Laborator Lithea sro	Brno, Czech Republic	Scrooby's Analytical Services	Benoni, South Africa

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognized reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1. N_{min} = \max(10, \sqrt[3]{N_{prod}})$$

$$2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Expiration

The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.


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